

**KURUKSHETRA UNIVERSITY KURUKSHETRA**  
(Established by the State Legislature Act XII of 1956)  
("A+" Grade NAAC Accredited)

**Date-sheet for the M.Sc. Electronics Science II Semester and M. Tech Microelectronics & VLSI Design  
II Semester Examinations commencing w.e.f. 04-05-2019.**

**(THEORY EXAMINATION)**

**Time of Examination : 9.30 A.M. to 12.30 P.M. (MORNING SESSION)**

**Examination Centre : 560, Department of Electronics Science, K.U. Kurukshetra**

<b>DATE</b>	<b>SUBJECT AND PAPER</b>
	<b>M.Sc. II Semester</b>
<b>4-May-2019</b>	EL- 21: Digital Circuits and System Design (CBCS Scheme 2016-17 onwards)
<b>8-May-2019</b>	EL-22: Device Models and Circuits Simulation (CBCS Scheme 2016-17 onwards)
<b>13-May-2019</b>	EL-23: Verilog-Hardware Description Language (CBCS Scheme 2016-17 onwards)
<b>17-May-2019</b>	EL-24: System Design Using Embedded Processors (CBCS Scheme 2016-17 onwards)
<b>22-May-2019</b>	EL-25: Opt(i) Foundations of MEMS (CBCS Scheme 2016-17 onwards)
<b>22-May-2019</b>	EL-25: Opt,(iii) Materials for VLSI (CBCS Scheme 2016-17 onwards)
<b>22-May-2019</b>	EL-25: Opt.(iv) Device Electronics for VLSI (CBCS Scheme 2016-17 onwards)
	<b>M.Tech. Microelectronics &amp; VLSI Design II Semester</b>
<b>4-May-2019</b>	MMVD-201: Process Technology for VLSI-II
<b>8-May-2019</b>	MMVD-202: Embedded System Design Using 8051
<b>13-May-2019</b>	MMVD-203: Analog CMOS Integrated Circuits
<b>17-May-2019</b>	MMVD-204: Verilog Hardware Description Language

- NOTES :**
- 1** On getting a question-paper and before answering it, the candidates must check up and ensure that they have been supplied with the correct question-paper. If the question-paper is not correct they should bring the same to the notice of the Invigilator. Complaints in this regard after the examination shall not be entertained.
  - 2** Electronics gadgets such as pagers, Cell phone and Programmable Calculators etc. are not allowed in the Examination Hall.
  - 3** No extra answer-sheet will be provided.

**KURUKSHETRA**  
27-Mar-2019

**CONTROLLER OF EXAMINATIONS**